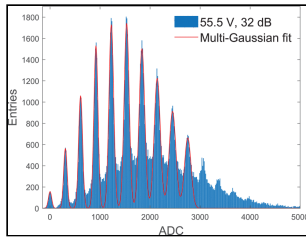


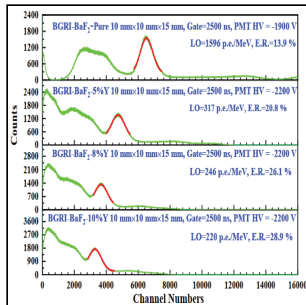
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by Massimo Caccia, Marco Galoppo, Luca Malinverno, Pietro Monti-Guarnieri, and Romualdo Santoro

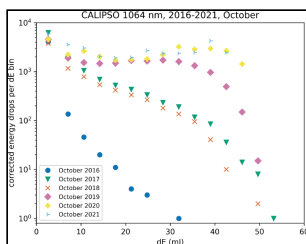
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